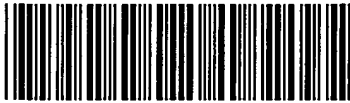


Search Notes

Application/Control No.

10/043,679

Examiner

Erin M. File

Applicant(s)/Patent under
Reexamination

MCREYNOLDS ET AL.

Art Unit

2634

SEARCHED

Class	Subclass	Date	Examiner
370	276	4/8/2005	EMF
375	219	4/8/2005	EMF
455	73	4/8/2005	EMF
455	1	4/8/2005	EMF

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM	4/8/2005	EMF
PALM INVENTORSHIP	4/8/2005	EMF
IEEE Keyword Search	4/10/2005	EMF